

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination
				10/814,037	RENAUD, ALAIN
				Examiner	Art Unit
				Michael J. Early	3744

SEARCHED			
Class	Subclass	Date	Examiner
62	404, 465, 337, 336, 255, 302		
	448, 440		
	371	12/15/2005	MJE
220	500, 528		
	529, 530		
	592.01		
	592.02		
	592.05	12/19/2005	MJE
Updated		4/28/06	MJE

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See PG Pub. search (EAST search attached)	4/28/06	MJE	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted Harry Tanner, Primary Examiner – A.U. 3744, regarding a search in: class 62/302, 448	12/15/2005	MJE
Consulted William Doerrler, Primary Examiner – A.U. 3744, regarding a search in: class 62/440, 371	12/15/2005	MJE
EAST - text search - see attached	12/19/2005	MJE
Performed a PLUS search for IFW applications – see attached	12/15/2005	MJE
Consulted Robin Hylton, Primary Examiner – A.U. 3727, regarding a search in: class 220/500, 528, 529, 530, 592.01	12/19/2005	MJE
Consulted Robin Hylton, Primary Examiner – A.U. 3727, regarding a search in: class 220/592.01, 592.02, 592.05	12/19/2005	MJE
Consulted EIC 3700 for a STIC search – see attached attached	2/9/06	MJE
Updated EAST search	4/28/06	MJE